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PCN Date: 10/10/2016	Effective Date: 1/13/2017			
Title: EFM8UB2 Revision B PCN				
PCN Type:				
⊠ Datasheet				
☑ Product Revision				
PCN Details				



Description of Change:

Silicon Labs is pleased to announce revision B of the EFM8UB2 devices, version 0.4 of the errata, and version 1.3 of the corresponding datasheet for these products.

Overview and major changes:

Addition of a USB Bootloader:

A "Bootloader Signature Byte" has been added to the EFM8UB2 to support a factory programmed bootloader.

- Each device will use the byte immediately before the Lock Byte as a Bootloader Signature Byte to determine if the bootloader is present in flash.

-Setting the Bootloader Signature Byte to a value of 0xA5 indicates the presence of the bootloader in the system. Any other value in this location indicates that the bootloader is not present in flash.

External oscillator pins:

-The external oscillator pins on the 32 pin packages are non-functional.

Datasheet version 1.3:

-Added information on the included bootloader described above.

-All part numbers in the datasheet now reflect the revision change with a 'B'.

-Added a section describing the typical connection for debugging EFM8UB2. This includes pin

sharing techniques of the C2 interface, refer to section 5.4 of the datasheet for more information. -In the introduction section a line was added to mention the reference manual where an individual can find more technical information on registers and blocks.

-Added Power-On Reset Threshold and Power-On Reset Delay specifications for a finite Vdd value and delay times.

-Added typical Cyclic Redundancy Check (CRC) Calculation Time for a read or write of a 256 byte block of flash at 48 MHz.

-Added VBUS Detection Input Low and Input High Voltage on the USB transceiver.

-Added a table on SMbus timing and operating frequency in master mode. The table details minimum and maximum operating frequency for each class, hold times, start times, clock low and clock high periods, and start and stop conditions.

-Added a note to the QFN32 and QFP32 devices that the external oscillator pins are non-functional. -Updated the recommended capacitor values attached to the power pins of a USB connected device with a voltage regulator.

-Added a recommended setup when using the EFM8UB2 as a USB connected device without the use of a voltage regulator.

Errata version 0.5:

-Added information on the bootloader described above.

After the effective date of this PCN, Silicon Labs reserves the right to deliver EFM8UB2 Rev B for customers ordering EFM8UB2 Rev A.

Reason for Change:

EFM8UB2 datasheet version 1.3 release

EFM8UB2 Revision B release

EFM8UB2 version 0.4 errata

Impact on Form, Fit, Function, Quality, Reliability:

This change is considered a minor change which does not affect form, fit, function, quality, or reliability.

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Revision Change Notice #1610101

Product Identification:

Existing Part Number	Replacement Part Number	Drop in Compatible Indicator
EFM8UB20F32G-A-QFN32	EFM8UB20F32G-B-QFN32	Yes
EFM8UB20F32G-A-QFN32R	EFM8UB20F32G-B-QFN32R	Yes
EFM8UB20F32G-A-QFP48	EFM8UB20F32G-B-QFP48	Yes
EFM8UB20F32G-A-QFP48R	EFM8UB20F32G-B-QFP48R	Yes
EFM8UB20F32G-A-QFP32	EFM8UB20F32G-B-QFP32	Yes
EFM8UB20F32G-A-QFP32R	EFM8UB20F32G-B-QFP32R	Yes
EFM8UB20F64G-A-QFN32	EFM8UB20F64G-B-QFN32	Yes
EFM8UB20F64G-A-QFN32R	EFM8UB20F64G-B-QFN32R	Yes
EFM8UB20F64G-A-QFP48	EFM8UB20F64G-B-QFP48	Yes
EFM8UB20F64G-A-QFP48R	EFM8UB20F64G-B-QFP48R	Yes
EFM8UB20F64G-A-QFP32	EFM8UB20F64G-B-QFP32	Yes
EFM8UB20F64G-A-QFP32R	EFM8UB20F64G-B-QFP32R	Yes

Note: The part numbers above include tape and reel variants which are denoted with an "R" at the end of the orderable part number.

Last Date of Unchanged Product: 1/13/2017

Qualification Samples:

Samples are available now. Please contact your Silicon Labs sales representative to order samples. A list of Silicon Labs sales representatives is available at <u>www.silabs.com</u>.

Specific conditions of acceptance of this change will be considered on a case by case basis if written notice is submitted within 30 days of this notice. To request further data or inquire about this notification, please contact your local Silicon Labs sales representative. A list of Silicon Labs sales representatives is available at <u>www.silabs.com</u>.

In some cases rejection of a change notice may impact Silicon Labs product pricing, delivery, quality, or reliability.

Customer Early Acceptance Sign Off:

Customers may approve early PCN acceptance by completing the information below:

Early Acceptance: Date: _____

Name:

Company: _____

Email your early Acceptance approval to: <u>katherine.haggar@silabs.com</u>

Qualification Data:

See below.

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EFM8UB20Fxxx Qualification Report



W7101F1 - Product Qualification Plan and Report Record Rev. G

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EFM8UB20Fxxx Rev B, GSMC Fabrication							
			Lot ID or	Fail/Pass or			
Test Name	Test Condition	Qualification	Start	End	Notes	Summary	Sta tus
Test Group A - A	ccelerated Environment Stres	s Tests - SPIL LQ	FP				
HAST	JA110		Q26065	0/80	1		
	130°C, 85%RH	3 lots, N⊨>25	Q25565	0/80	1	3 lots	Pass
	Vcc=3.6V, 96 hours		Q25562	0/80	1	0/240	
Temp Cycle	JA104		Q26067	0/80	1		
	Cond C: -65°C to 150°C	3 lots, N⊨>25	Q26127	0/80	1	3 lots	Pass
	500 cycles		Q25560	0/80	1	0/240	
HTTSL	JA103		Q26064	0/80			
	150°C, 1000hr	3 lots, N⊨>25	Q25563	0/80		3 lots	Pass
			Q25566	0/80		0/240	
Test Group A - A	ccelerated Environment Stres	s Tests - AŒCL ()FN				
HAST	JA110		Q29241	0/77	2		
	130°C, 85%RH	3 lots, N⊨>25	Q29246	0/80	2	3 lots	Pass
	Vcc=3.6V, 96 hours		Q30240	0/80	2	0/237	
Temp Cycle	JA104		Q29243	0/78	2		
	Cond C: -65°C to 150°C	3 lots, N⊨>25	Q29248	0/80	2	3 lots	Pass
	500 cycles		Q30237	0/79	2	0/237	
HTSL	JA103		Q29244	0/78	2		
	150°C, 1000hr	3 lots, N⊨>25	Q29249	0/79	2	3 lots	Pass
			Q30239	0/80	2	0/237	
Test Group A - A	ccelerated Environment Stres	s Tests - SPIL TQ	FP				
HAST	JA110		Q25572	0/80	3		
	130°C, 85%RH	3 lots, N⊨>25	Q25669	0/80	3	3 lots	Pass
	Vcc=3.6V, 96 hours		Q26807	0/27	3	0/187	
Temp Cycle	JA104		Q26438	0/82	3		
	Cond C: -65°C to 150°C	3 lots, N⊨>25	Q26443	0/80	3	3 lots	Pass
	500 cycles		Q27775	0/31	3	0/193	
HTSL	JA103		Q25573	0/80	3		
	150°C, 1000hr	3 lots, N⊨>25	Q25663	0/80	3	3 lots	Pass
			Q26805	0/27	3	0/187	

Prepared on: 16-Aug-16

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Revision Change Notice #1610101

EFM8UB20Fxxx Qualification Report



W7101F1 - Product Qualification Plan and Report Record Rev. G

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EFM8UB20Fxxx Rev B, GSMC Fabrication							
Test Group B - Accelerated Lifetime Simulation Tests							
HTOL	JA108		Q29645	0/80			
	125°C, Dynamic	3 lots, N⊨>77	Q28080	0/91		3 lots	Pass
	Vcc=5.5V, 1000 hours		Q27686	0/82		0/253	
LTOL	JA108						
	-10°C, Dynamic	1 lot, N⊨>32				1 lots	Pass
	Vcc=5.5V, 1000 hours		Q26491	0/41		0/41	
ELFR	JA108		Q29593	0/505			
	125°C, Dynamic	3 lots, N⊨>500	Q29898	0/520		3 lots	Pass
	Vcc=5.5V, 48 hours		Q31030	0/504		0/1529	
Test Group E - E	lectrical Verification						
ESD-HBM	JA114						
		1 lot, N⊨>3	Q29448				2000 V
ESD-AWA	JA115						
		1 lot, N⊨>3	Q29449				225 V
ESD-CDM	JC101		Q30041				
		1 lot, N⊨>3	Q30039				2000 V
			Q29447				
Latch Up	JESD78						
	±200m A	1 lot, N⊨>3	Q29445	25 C			Pass
			Q29446	85 C			

Notes:

1. Parts are Pre-conditioned at MSL3/260°C

2. Parts are Pre-conditioned at MSL1/260°C

3. Parts are Pre-conditioned at MSL2/260°C

This report applies to the following part numbers:				
EFW8UB20F64G-B-QFP48	E FM8UB20F64G-B-QFN32			
EFW8UB20F32G-B-QFP48	E F//8UB20F32 G-B-QFN32			
EFW8UB20F64G-B-QFP32				
EFW8UB20F32G-B-QFP32				

Approved by: Vincent Hidajat

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